

Notice of References Cited	Application/Control No. 10/588,318		Applicant(s)/Patent Under Reexamination NAKAMURA ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0134026	09-2002	Fujii et al.	51/295
	B	US-			
	C	US-			
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	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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NON-PATENT DOCUMENTS

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